

APPLICATION NOTE

CONFIDENTIAL

MITSUBISHI IGBT MODULES

CM1800DY-34S

HIGH POWER SWITCHING USE
INSULATED TYPE

Revision B

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Checked by	
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Date	9-Sep-'10

PRELIMINARY

Notice: This is not a final specification. Some parametric limits are subject to change.

1800A/1700V



Dual (Half-Bridge)

- Using New IGBT and FWDi -

- I_c 1800 A
- V_{CES} 1700 V
- Flat base Type
Aluminium base plate
- RoHS Directive compliant
- UL under application

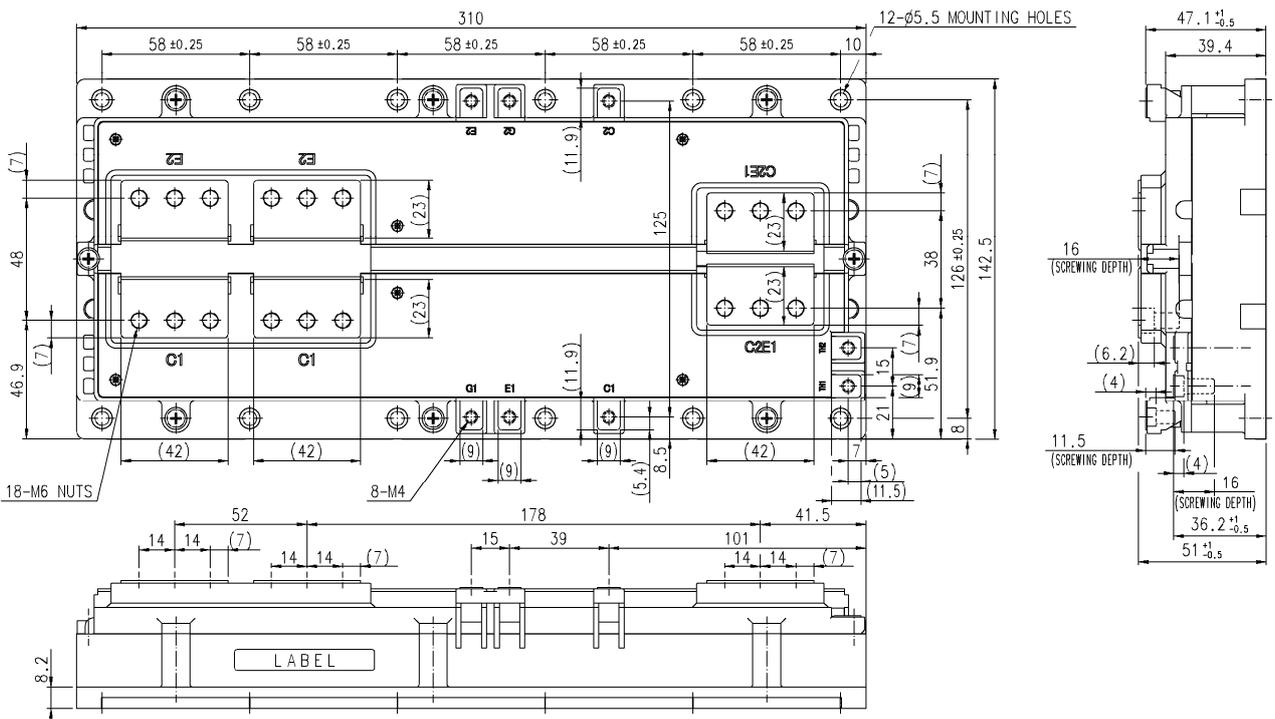
APPLICATION

Wind power, AC Motor Control, Power supply, etc.

OUTLINE DRAWING & CIRCUIT DIAGRAM

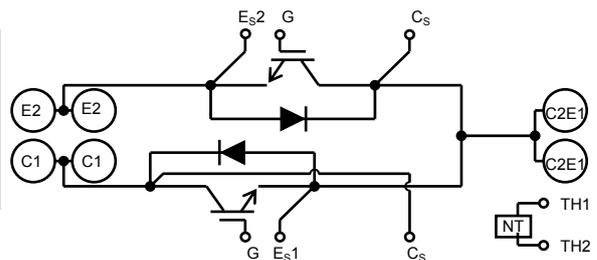
Dimension in mm

A B



CIRCUIT DIAGRAM

Tolerance otherwise specified	
Division of Dimension	Tolerance
0.5 to 3	±0.2
over 3 to 6	±0.3
over 6 to 30	±0.5
over 30 to 120	±0.8
over 120 to 400	±1.2



Note: Main terminal pair should be connected together in case of the current through it.

PRELIMINARY

ABSOLUTE MAXIMUM RATINGS ($T_j=25\text{ }^\circ\text{C}$, unless otherwise specified)

Inverter IGBT/FWDi part

Symbol	Item	Conditions	Ratings	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1700	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, $T_C=89\text{ }^\circ\text{C}$ (Note.2)	1800	A
I_{CRM}		Pulse (Note.3)	3600	
P_{tot}	Total power dissipation	$T_C=25\text{ }^\circ\text{C}$ (Note.2, 4)	9350	W
I_E (Note.1)	Emitter current	$T_C=25\text{ }^\circ\text{C}$ (Note.2, 4)	1800	A
I_{ERM} (Note.1)	(Free wheeling diode forward current)	Pulse (Note.3)	3600	

Module

Symbol	Item	Conditions	Ratings	Unit
T_{jmax}	Maximum junction temperature	-	+175	$^\circ\text{C}$
T_{jop}	Operating junction temperature	-	-40 ~ +150	
T_{stg}	Storage temperature	-	-40 ~ +125	
T_C	Case temperature	-	-40 ~ +125	
V_{isol}	Isolation voltage	Terminals to base plate, f=60 Hz, AC 1 minute	3500	V_{rms}

Note.1: Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).

Note.2: Case temperature (T_C) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)

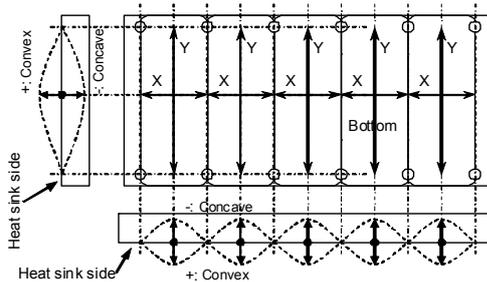
Note.3: Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.

Note.4: Junction temperature (T_j) should not increase beyond T_{jmax} rating.

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals M 6 screw	3.5	4.0	4.5	N·m
M_t		Auxiliary terminals M 4 screw	1.3	1.5	1.7	
M_s		Mounting M 5 screw	2.5	3.0	3.5	
d_s	Creepage distance	Terminal to terminal	16	-	-	mm
		Terminal to base plate	25	-	-	
d_a	Clearance	Terminal to terminal	16	-	-	mm
		Terminal to base plate	24	-	-	
m	Weight	-	-	2000	-	g
e_c	Flatness of base plate	On the centerline X, Y (Note.5)	-50	-	+100	μm

Note.5: Base plate flatness measurement point is as in the following figure.



PRELIMINARY

ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

Inverter IGBT/FWDi part

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{CEs}	Collector-emitter cut-off current	V _{CE} =V _{CEs} , V _{GE} short-circuited	-	-	1	mA	
I _{GES}	Gate-emitter leakage current	±V _{GE} =V _{GES} , V _{CE} short-circuited	-	-	5	μA	
V _{GE(th)}	Gate-emitter threshold voltage	I _C =180 mA, V _{CE} =10 V	5.4	6.0	6.6	V	
V _{CEsat}	Collector-emitter saturation voltage	I _C =1800 A ^(Note.6) , V _{GE} =15 V, Terminal	T _j =25 °C	-	2.30	2.80	V
			T _j =125 °C	-	2.50	-	
			T _j =150 °C	-	2.55	-	
		I _C =1800 A, V _{GE} =15 V, Chip	T _j =25 °C	-	2.10	2.60	V
			T _j =125 °C	-	2.30	-	
			T _j =150 °C	-	2.35	-	
C _{ies}	Input capacitance	V _{GE} short-circuited, V _{CE} =10 V	-	-	460	nF	
C _{oes}	Output capacitance		-	-	48		
C _{res}	Reverse transfer capacitance		-	-	8		
Q _G	Gate charge	V _{CC} =1000 V, I _C =1800 A, V _{GE} =15 V	-	8400	-	nC	
t _{d(on)}	Turn-on delay time	V _{CC} =1000 V, I _C =1800 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load	-	-	1100	ns	
t _r	Rise time		-	-	200		
t _{d(off)}	Turn-off delay time		-	-	950		
t _f	Fall time		-	-	500		
t _{rr} ^(Note.1)	Reverse recovery time	V _{CC} =1000 V, I _E =1800 A, V _{GE} =15 V,	-	-	350	μC	
Q _{rr} ^(Note.1)	Reverse recovery charge	R _G =0 Ω, Inductive load	-	360	-		
E _{on}	Turn-on switching energy	V _{CC} =1000 V, I _C =I _E =1800 A,	-	510	-	mJ	
E _{off}	Turn-off switching energy	V _{GE} =±15 V, R _G =0 Ω, T _j =150 °C,	-	545	-		
E _{rr} ^(Note.1)	Reverse recovery energy	Inductive load, Per pulse	-	490	-		
V _{EC} ^(Note.1)	Emitter-collector voltage	I _E =1800 A ^(Note.6) , V _{GE} =0 V, Terminal	T _j =25 °C	-	2.1	(2.6)	V
			T _j =125 °C	-	2.2	-	
			T _j =150 °C	-	2.15	-	
		I _E =1800 A, V _{GE} =0 V, Chip	T _j =25 °C	-	1.9	(2.4)	V
			T _j =125 °C	-	2.0	-	
			T _j =150 °C	-	1.95	-	
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per switch, T _C =25 °C ^(Note.2)	-	0.11	-	mΩ	
r _g	Internal gate resistance	Per switch	-	1.1	-	Ω	

NTC thermistor part

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R ₂₅	Zero power resistance	T _C =25 °C ^(Note.2)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	T _C =100 °C, R ₁₀₀ =493 Ω	-7.3	-	+7.8	%
B _(25/50)	B constant	Approximate by equation ^(Note.7)	-	3375	-	K
P ₂₅	Power dissipation	T _C =25 °C ^(Note.2)	-	-	10	mW

Note.1: Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).

Note.2: Case temperature (T_C) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)

Note.3: Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.

Note.4: Junction temperature (T_j) should not increase beyond T_{jmax} rating.

Note.6: Pulse width and repetition rate should be such as to cause negligible temperature rise.

(Refer to the figure of test circuit)

$$\text{Note.7: } B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$$

R₂₅: resistance at absolute temperature T₂₅ [K]; T₂₅=25 [°C]+273.15=298.15 [K]

R₅₀: resistance at absolute temperature T₅₀ [K]; T₅₀=50 [°C]+273.15=323.15 [K]

PRELIMINARY

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance (Note.2)	Junction to case, per Inverter IGBT	-	-	16	K/kW
$R_{th(j-c)R}$		Junction to case, per Inverter FWDi	-	-	27	K/kW
$R_{th(c-s)}$	Contact thermal resistance (Note.2, 9)	Case to heat sink, per 1 module, Thermal grease applied (Note.8)	-	3.1	-	K/kW

Note.2: Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)

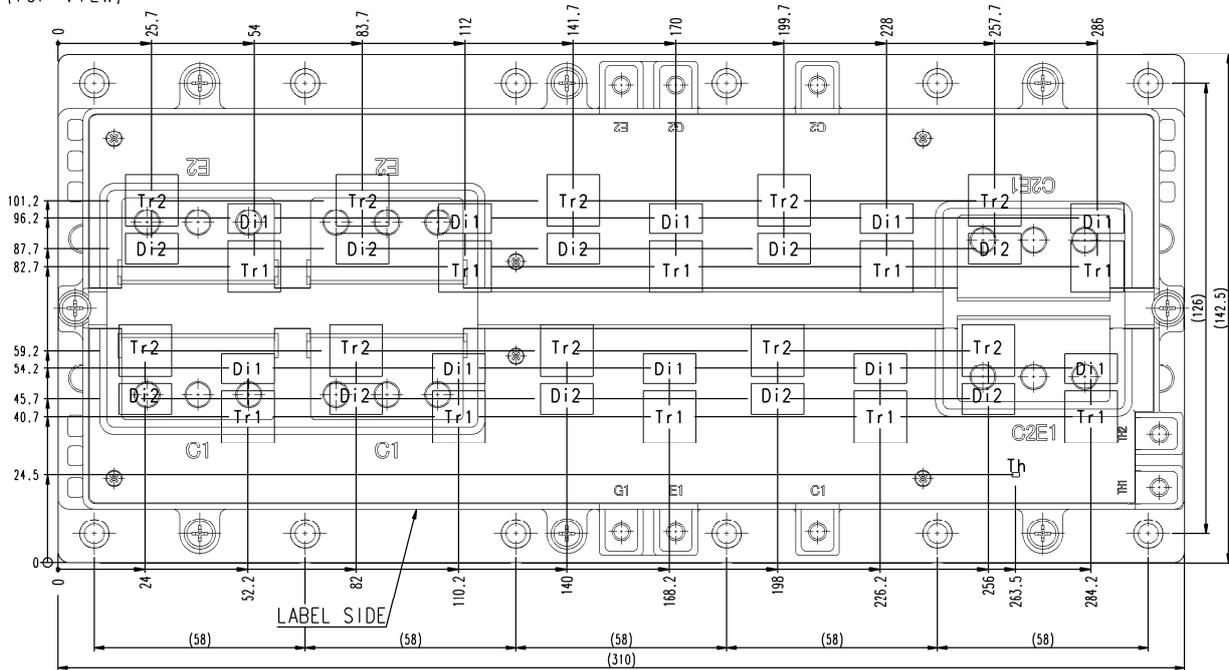
Note.8: Typical value is measured by using thermally conductive grease of $\lambda=0.9$ W/(m·K).

Note.9: When liquid-cooling, actual $R_{th(c-s)}$ should be used by measurement on each heat sink.

CHIP LOCATION (Top view)

Dimension in mm (tolerance: ± 1 mm)

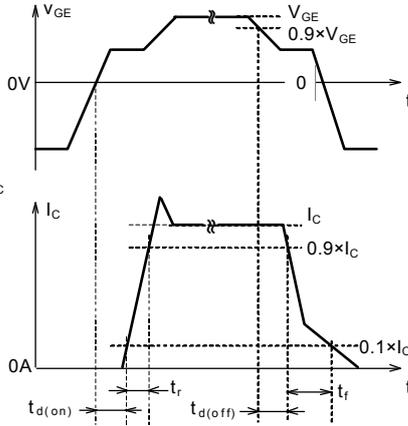
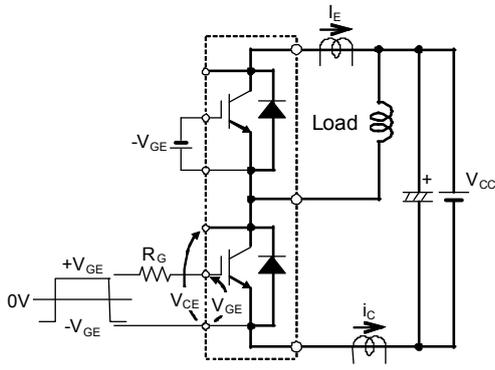
[TOP VIEW]



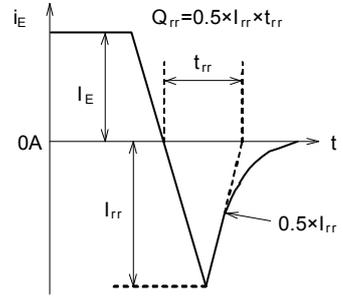
Each mark points the center position of each chip. Tr1/Tr2: IGBT, Di1/Di2: FWDi, Th: Thermistor

PRELIMINARY

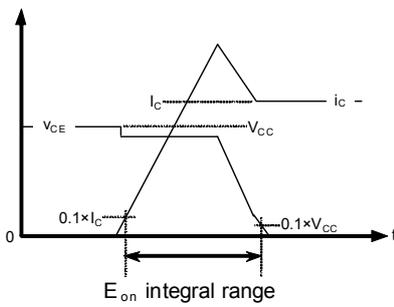
TEST CIRCUIT and WAVEFORMS



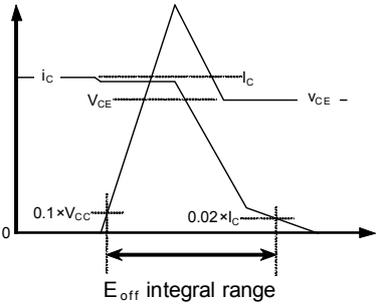
Switching time test circuit and waveforms



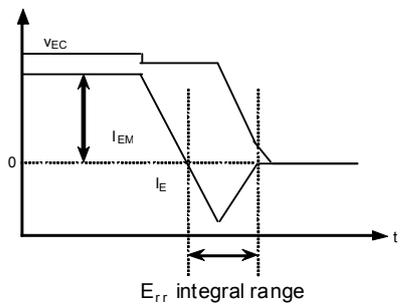
t_{rr} , Q_{rr} test waveform



IGBT Turn-on energy

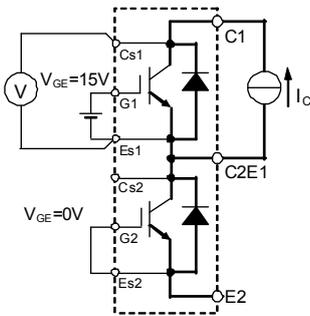


IGBT Turn-off energy



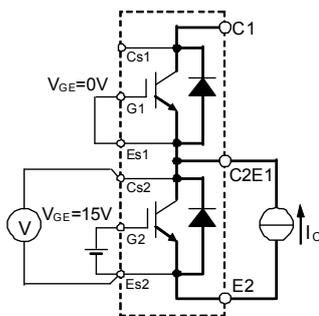
FWDi reverse recovery energy

Switching energy (per pulse) test waveforms

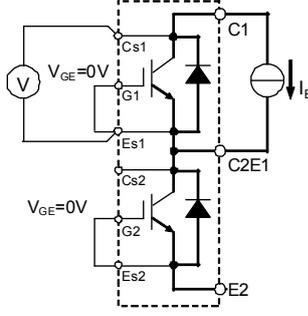


Tr1

V_{CEsat} test circuit

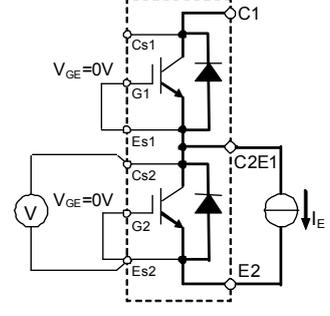


Tr2



Di1

V_{EC} test circuit



Di2

CM1800DY-34S

HIGH POWER SWITCHING USE

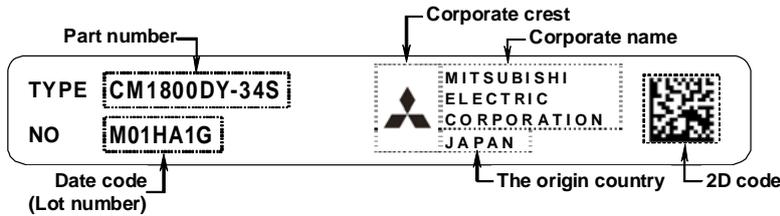
INSULATED TYPE

PRELIMINARY

RECOMMENDED OPERATING CONDITIONS (T_a=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V _{CC}	DC supply voltage	Applied across P-N terminals	-	1000	1200	V
V _{GEon}	Gate-emitter drive voltage	Applied across G-E terminals	13.5	15.0	16.5	
R _G	External gate resistance	-	0	-	2	Ω

LABEL EXAMPLE and 2D CODE SPECIFICATION



2D code specification

Item	Specification
Symbology	Data Matrix (ECC200)
Data type	alphanumeric (ASCII) character
Error correction ability	20 ~ 35 %
Symbol size	6.0 mm × 6.0 mm
Cell size	0.25 mm
Code size	24 cell × 24 cell
Data size	32 characters

Data contents

Item	letter size
Part number	20
Space	2
Date code	8
Space	2
total	32

Data contents example("sp" means space, equivalent to ASCII code number 32)

1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	31	32
C	M	1	8	0	0	D	Y	-	3	4	S	sp	M	0	1	H	A	1	G	sp	sp	sp									

PRELIMINARY

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CM1800DY-34S
HIGH POWER SWITCHING USE
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